

**Search Notes**

Application/Control No.

10/774,924

Examiner

David M. Fenstermacher

Applicant(s)/Patent under  
Reexamination

CHANG, HSUEH CHIN

Art Unit

3682

**SEARCHED**

Class	Subclass	Date	Examiner
184	1.5		
	105.1		
	105.3		
	106	12/7/2006	DMF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR